

**Search Notes**

Application/Control No.

10/582,608

Examiner

Maria Veronica D. Ewald

Applicant(s)/Patent under  
Reexamination

AKISHEV ET AL.

Art Unit

1791

**SEARCHED**

Class	Subclass	Date	Examiner
425	89	12/18/2007	MVE
425	369	12/18/2007	MVE
425	394	12/18/2007	MVE
425	396	12/18/2007	MVE
425	403	12/18/2007	MVE
425	411	12/18/2007	MVE
72	385	12/18/2007	MVE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search in eDAN	12/18/2007	MVE
Searched in WIPO and EPO for PCT document, references cited	12/18/2007	MVE
Searched similar cases filed by inventor and reviewed prior art cited in those cases	12/18/2007	MVE